

# Effect of Vacuum Annealing on the Thermal Stability of $\text{Ti}_3\text{SiC}_2/\text{TiC}/\text{TiSi}_2$ Composites

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## Abstract

Titanium silicon carbide ( $\text{Ti}_3\text{SiC}_2$ ) possesses a unique combination of properties of both metals and ceramics, for it is thermally shock resistant, thermally and electrically conductive, damage tolerant, lightweight, highly oxidation resistant, elastically stiff, and mechanically machinable. In this research, the effect of high vacuum annealing on the phase stability and phase transitions of  $\text{Ti}_3\text{SiC}_2/\text{TiC}/\text{TiSi}_2$  composites up to  $1550^\circ\text{C}$  was studied using *in-situ* neutron diffraction. The role of TiC and  $\text{TiSi}_2$  on the thermal stability of  $\text{Ti}_3\text{SiC}_2$  during vacuum annealing is discussed. TiC reacts with  $\text{TiSi}_2$  between  $1400\text{--}1450^\circ\text{C}$  to form  $\text{Ti}_3\text{SiC}_2$ . Above  $1400^\circ\text{C}$ , decomposition of  $\text{Ti}_3\text{SiC}_2$  into TiC commenced and the rate increased with increased temperature and dwell time. Furthermore, the activation energy for the formation and decomposition of  $\text{Ti}_3\text{SiC}_2$  was determined.

**Keywords:** MAX phase, thermal stability, vacuum-annealing, decomposition,  $\text{Ti}_3\text{SiC}_2$ , neutron diffraction.

## INTRODUCTION

Many attempts have been made to produce new materials with a unique combination of the ductility, conductivity, and machinability of metals, and with the high strength, high modulus, high thermal stability, and superior high-temperature-oxidation resistance of ceramics. Ternary carbides, such as  $\text{Ti}_3\text{SiC}_2$  and  $\text{Ti}_3\text{AlC}_2$ , are hexagonal layered compounds belonging to a family with the general formula:  $M_{n+1}AX_n$ , where  $n$  is 1, 2 or 3,  $M$  is an early transition metal,  $A$  is an A-group (mainly group III-A and IV-A) element, and  $X$  is either carbon or nitrogen [1-12].  $\text{Ti}_3\text{SiC}_2$  has high toughness, high Young's modulus, low hardness, and moderate flexural strength. Furthermore, it exhibits plasticity at high temperature, good electrical conductivity, high thermal shock resistance, and good machinability [3, 5, 7, 9, 11, 13]. The salient combination of properties makes ternary carbides ideal candidate materials for high-temperature applications.

The thermal stability of  $\text{Ti}_3\text{SiC}_2$  in vacuum has attracted little attention [10, 14-16]. Emmerlich *et al.* [14] investigated the thermal stability of  $\text{Ti}_3\text{SiC}_2$  thin films and reported that the rapid decomposition of  $\text{Ti}_3\text{SiC}_2$ , associated with Si out-diffusion and detwinning of as-relaxed  $\text{Ti}_3\text{C}_2$  slabs into oriented  $\text{TiC}_{0.67}$  layers, is observed when annealing at  $1100\text{--}$

$1200^\circ\text{C}$ . Radhakrishnan *et al.* [16] reported similar results for the decomposition of  $\text{Ti}_3\text{SiC}_2$  in vacuum and stated that  $\text{Ti}_3\text{SiC}_2$  did not dissociate up to  $1800^\circ\text{C}$  but was found susceptible to carburization and oxidation. Oo *et al.* [15] studied the thermal stability of  $\text{Ti}_3\text{SiC}_2$  in argon with low oxygen partial pressure and reported that  $\text{Ti}_3\text{SiC}_2$  decomposed into TiC and  $\text{Ti}_5\text{Si}_3\text{C}_x$ . Sun *et al.* [10] reported the occurrence of transformation between  $\alpha$ - and  $\beta$ -  $\text{Ti}_3\text{SiC}_2$ , and that  $\alpha$ - $\text{Ti}_3\text{SiC}_2$  is more stable than  $\beta$ - $\text{Ti}_3\text{SiC}_2$ .

It is difficult to synthesize a  $\text{Ti}_3\text{SiC}_2$  sample with 100 % purity due to its high propensity to dissociate into TiC. As indicated in the Ti-Si-C phase diagram (Fig. 1), the equilibrium state of a single phase of  $\text{Ti}_3\text{SiC}_2$  only occupies a small area which is intersected by the boundaries of TiC, SiC, and  $\text{TiSi}_2$ . In this study, two Maxthal  $\text{Ti}_3\text{SiC}_2$  samples with different amounts of TiC and  $\text{TiSi}_2$  were used. The role of TiC and  $\text{TiSi}_2$  on the thermal stability and phase transition of  $\text{Ti}_3\text{SiC}_2$  was investigated using *in-situ* high-temperature neutron diffraction. Furthermore, a comparison of surface composition in as-received and annealed samples was investigated by flat-plate synchrotron radiation diffraction (SRD).

## EXPERIMENTAL

### Sample Preparation

Maxthal  $\text{Ti}_3\text{SiC}_2$  samples (15 mm in diameter and 50 mm in length) were fabricated using a proprietary method developed by Kanthal AB, Sweden. The density of these samples was  $\sim 4.47 \text{ g/cm}^3$  with  $\sim 1\%$  porosity. Two Maxthal  $\text{Ti}_3\text{SiC}_2$  samples (A and B) with different amounts of TiC and  $\text{TiSi}_2$  were used. The contents of TiC and  $\text{TiSi}_2$  present in Samples A and B were 34.8 and 7.0 mol %, and 50.8 and 9.9 mol %, respectively.

### In-situ neutron diffraction

The collection of high-temperature *in-situ* neutron diffraction data was conducted using Wombat (the high-intensity neutron powder diffractometer) at the OPAL source in Australia. Data were collected using neutrons with incident wavelength of  $\lambda = \sim 1.660 \text{ \AA}$  from  $15$  to  $135^\circ 2\theta$  at a separation of  $0.125^\circ$ , with the use of the oscillating tertiary collimator. Rietica 1.7.7 was used for phase identification and Rietveld refinement. The optimized parameters during refinement were background coefficients, zero-shift error, peak shape parameters, cell parameters, and anisotropic thermal factors. The residual values of the refinement, statistical reliability factor of Bragg ( $R_B$ ), R-weighted pattern ( $R_{wp}$ ), R-expected ( $R_{exp}$ ), and the goodness-of-fit ( $\chi^2$ ), were evaluated. In Rietica,  $\chi^2$  is defined as the square of the ratio of  $R_{wp}$  to  $R_{exp}$ . Solid cylindrical bars with dimensions 15 mm (diameter) x 20 mm (height) cut from as-received samples were used in this study. The temperature of the sample environment was controlled by a closed cylindrical niobium vacuum furnace ( $10^{-6}$ - $10^{-8}$  torr). The sample was held by vanadium wire and heated to  $1550^\circ\text{C}$  according to the heating protocol shown in Fig. 2. Diffraction patterns were collected every minute.

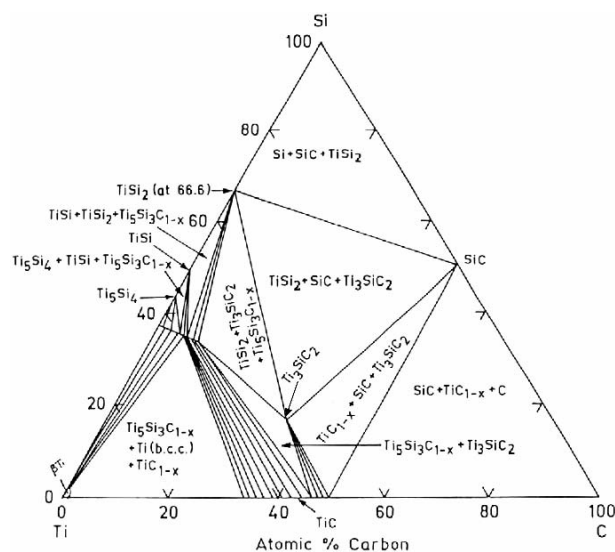


Fig. 1: Ti-Si-C ternary phase diagram at isothermal section at  $1250^\circ\text{C}$  [17].

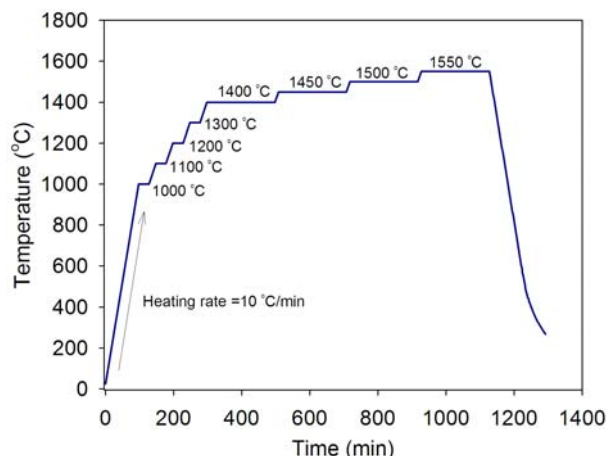


Fig. 2: Heating protocol for *in-situ* high-temperature neutron diffraction experiment.

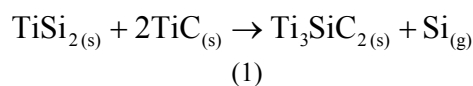
### Synchrotron radiation diffraction (GISRD)

The diffraction patterns were collected using BIGDIFF (the synchrotron powder diffractometer) at the Australian Synchrotron Research Program Facility (ANBF), beam-line BL-20B, at the Photon Factory, KEK, Tsukuba, Japan. The diffractograms were recorded from  $3^\circ$  to  $145^\circ 2\theta$  with a step size of  $0.01^\circ$ . The computer program “*DIFFRAPLUS EVA*” was used to identify the crystalline phases present. A diamond blade was used to cut thin slices ( $\sim 1 \text{ mm}$  thick) from the as-received and as-annealed samples. The slices were cleaned ultra-sonically prior to SRD experiment. The compositional information was measured using flat-plate SRD and image plates were used to record the diffraction patterns at  $3.0^\circ$  with a wavelength of  $0.7\text{ \AA}$ .

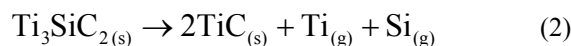
## RESULTS AND DISCUSSION

### Phase Transition during Vacuum Annealing

Results in Fig. 3a and 3b show the phase transition of Sample A and Sample B annealed in vacuum at temperature up to  $1550^\circ\text{C}$ . For Sample A,  $\text{TiSi}_2$  reacted with TiC during vacuum annealing to form  $\text{Ti}_3\text{SiC}_2$  at temperatures above  $1300^\circ\text{C}$  as follows:



This reaction resulted in the increased amounts of  $\text{Ti}_3\text{SiC}_2$ . By  $1500^\circ\text{C}$ ,  $\text{TiSi}_2$  was fully consumed to form  $\text{Ti}_3\text{SiC}_2$ , and at the same time, a pronounced decrease in  $\text{Ti}_3\text{SiC}_2$  content from  $65.4 \pm 1.22$  to  $58.3 \pm 1.22$  mol % was observed. The reduction of  $\text{Ti}_3\text{SiC}_2$  with a complementary increase in TiC suggests that the decomposition of  $\text{Ti}_3\text{SiC}_2$  into TiC occurs (via the sublimation of Ti and Si gaseous) as follows:



On the other hand, Sample B, consisting of more TiC than Sample A, showed better stability in vacuum. Here,  $Ti_3SiC_2$  also formed from the reaction of  $TiSi_2$  and TiC at 1400-1500 °C. Once  $TiSi_2$  was depleted, there was only a small decrease in  $Ti_3SiC_2$  content from 1500 to 1550 °C. However, within experimental and/or calculation errors, the  $Ti_3SiC_2$  decomposition was not clearly observed, which implies better thermal stability for Sample B in vacuum at up to 1550 °C.

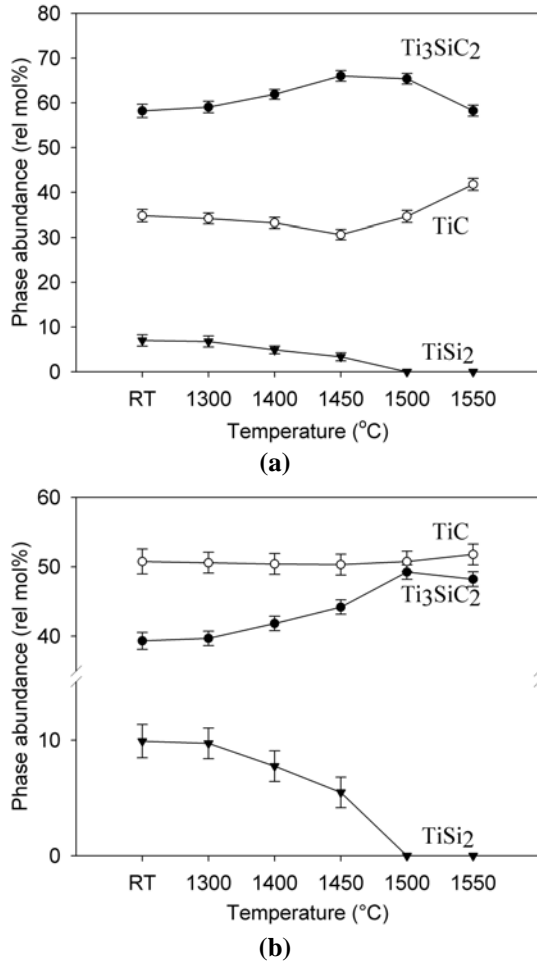


Fig. 3: Phase abundance as a function of temperature during vacuum annealing for (a) Sample A and (b) Sample B.

Table 1: Phase abundances before and after vacuum treatment for sample A and B.

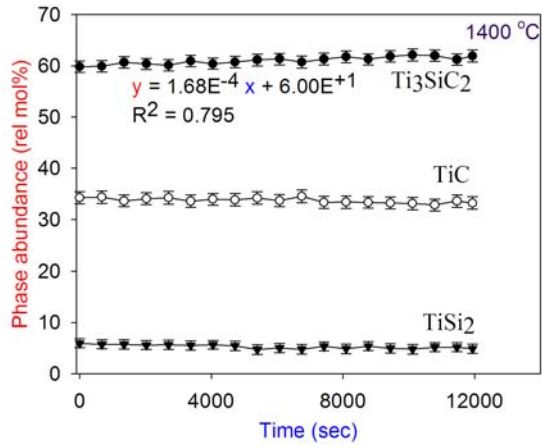
Phases	Phase abundance (rel. mol%)			
	Sample A		Sample B	
	Before	After	Before	After
$Ti_3SiC_2$	58.2±1.48	58.3±1.19	39.3±1.46	48.2±1.22
TiC	34.8±1.40	41.8±1.41	50.8±1.34	51.8±1.36
$TiSi_2$	7.0±1.28	0	9.9±1.30	0

A comparison of phase abundances between Samples A and B before and after vacuum annealing is summarized in Table 1. It shows that the consumption of  $TiSi_2$  did not contribute to the increase of  $Ti_3SiC_2$  in Sample A, but did increase the amount of  $Ti_3SiC_2$  in Sample B. In other words, Sample A underwent more decomposition, even though the relative molar fraction of  $Ti_3SiC_2$  content remained 58.3±1.19 mol%.

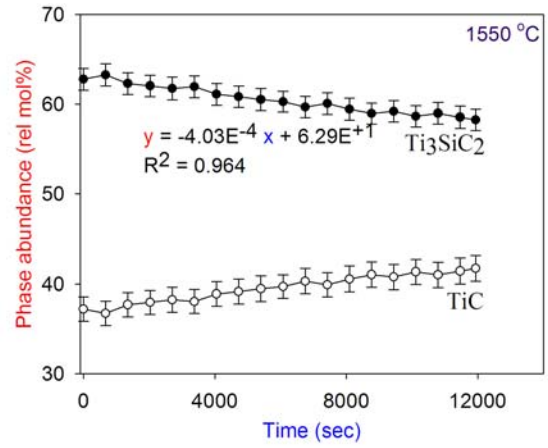
Figs. 4 and 5 show the isothermal phase transition at 1400, 1450, 1500, and 1550°C for Sample A and Sample B, respectively. The results show that phase abundance varies as a linear function of dwell time (< 200 minutes). The slope of  $Ti_3SiC_2$  regression lines can be treated as the rate for either decomposition (negative) or reformation (positive). It is noted that the decomposition rate increases with temperature.

For Sample A, the plots show slopes with positive values at 1400 and 1450°C and negative at 1500 and 1550°C, consistent with reformation and decomposition of  $Ti_3SiC_2$  occurring at these temperatures, respectively. Assuming that the decomposition of  $Ti_3SiC_2$  commenced at ≤1400°C, the increased  $Ti_3SiC_2$  content for Sample B implies that the reformation and decomposition of  $Ti_3SiC_2$  appeared rapidly and that the reaction rate for the decomposition was smaller.

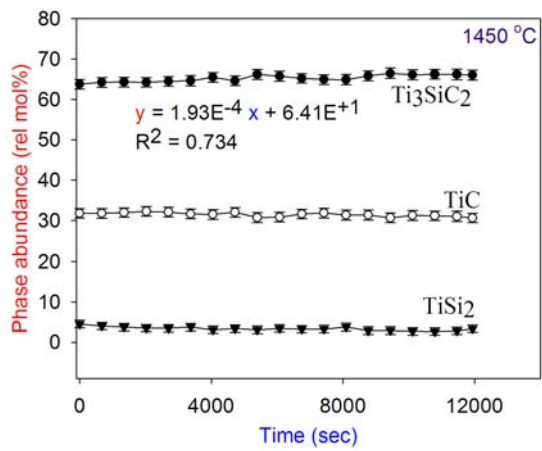
For Sample B, only the formation of  $Ti_3SiC_2$  was clearly observed. At 1500 and 1550°C, TiC and  $Ti_3SiC_2$  were in an equilibrium state, no decomposition or reformation was observed. The ratio of TiC:  $Ti_3SiC_2$  = ~1:1 may infer that the concentration of TiC affects the rate of  $Ti_3SiC_2$  decomposition and a compound with 50 mol%  $Ti_3SiC_2$  and 50 mol % TiC may be stable in vacuum up to 1550 °C.



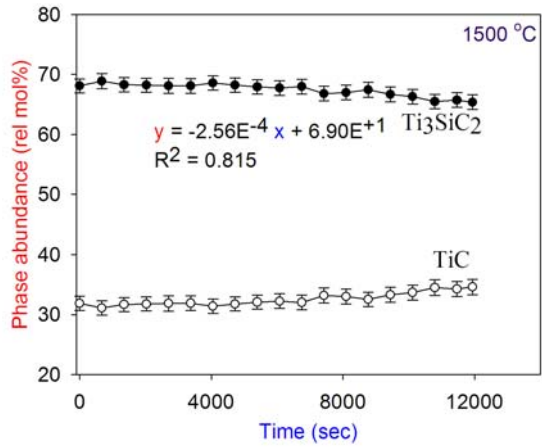
(a)



(d)

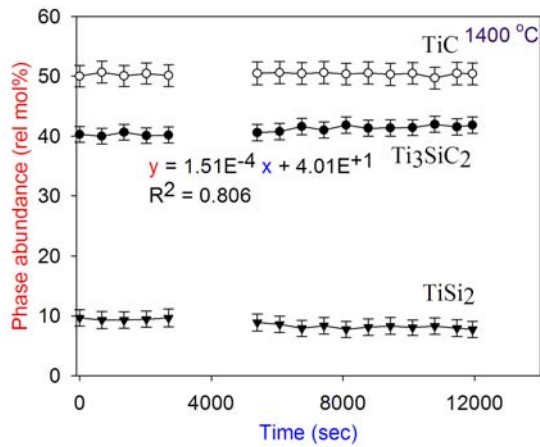


(b)

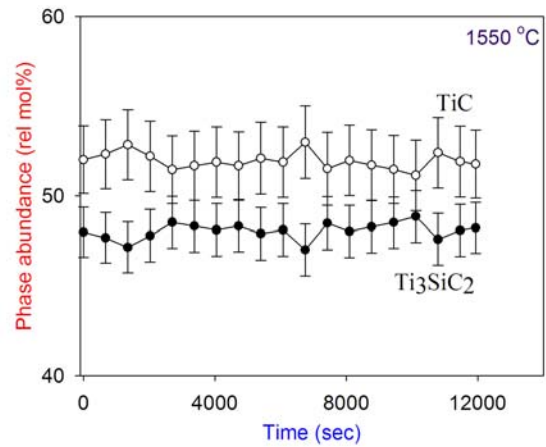


(c)

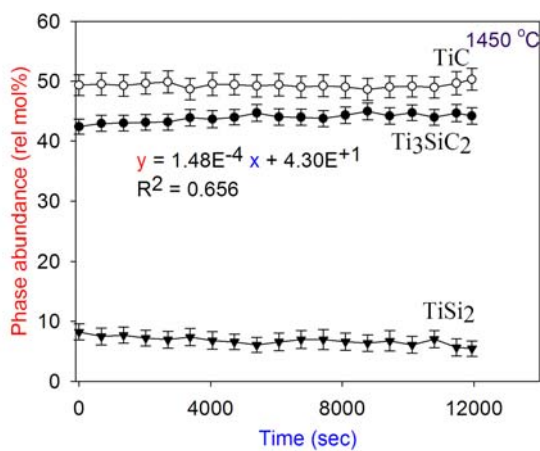
Fig. 4: Phase abundance as a function of dwell time at (a) 1400, (b) 1450, (c) 1500, and (d) 1550°C for sample A.



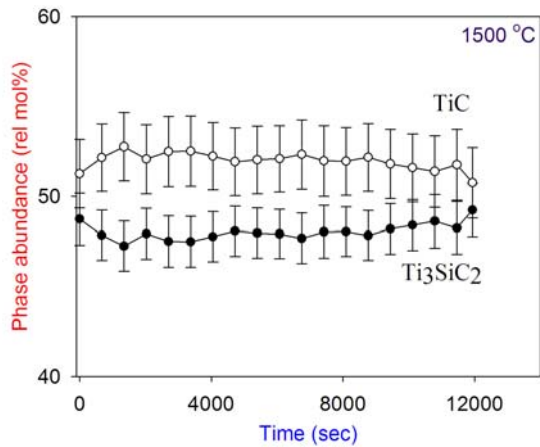
(a)



(d)



(b)



(c)

Fig. 5: Phase abundance as a function of dwell time at (a) 1400, (b) 1450, (c) 1500, and (d) 1550°C for sample B. Note that sections of data in (a) were not obtained due to equipment malfunction.

**Comparison of near-surface composition in samples before and after thermal decomposition**

Fig. 6 shows the comparison of near-surface composition in Samples A and B before and after vacuum-annealing at up to 1550°C. Several unknown peaks were observed in the annealed samples. These unknown peaks could not be identified by the “*DIFFRA<sup>plus</sup>* EVA” program, which suggests that the unknown phase formed is not in the current ICSD or PDF database. This implies that the thermal dissociation process is more complex than has been anticipated. Further work will be required to ascertain the actual chemistry of the thermal dissociation of  $Ti_3SiC_2$  containing  $TiSi_2$  and  $TiC$  as second phases.

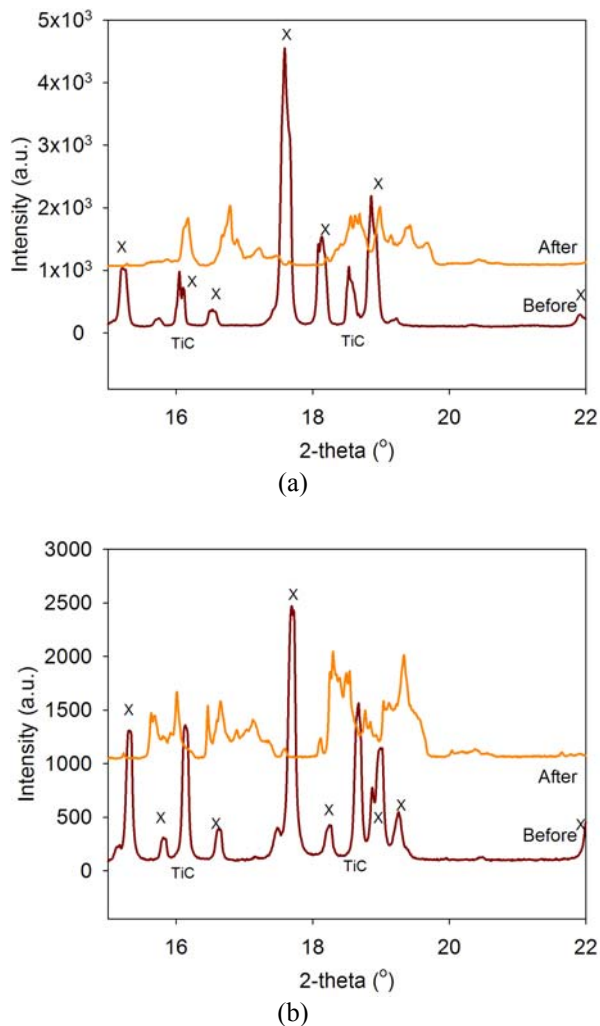


Fig. 6: Comparison of near-surface composition in (a) Sample A and (b) Sample B before and after vacuum annealing. (Legend: X:  $\text{Ti}_3\text{SiC}_2$ )

## CONCLUSIONS

A comparative study on the thermal stability of  $\text{Ti}_3\text{SiC}_2$  with various contents of TiC and  $\text{TiSi}_2$  was conducted using *in-situ* neutron diffraction. When annealed in vacuum at an elevated temperature, TiC and  $\text{TiSi}_2$  reacted to form  $\text{Ti}_3\text{SiC}_2$ , but at the same time  $\text{Ti}_3\text{SiC}_2$  decomposed into TiC (via the sublimation of Ti and Si). We find here that the reformation of  $\text{Ti}_3\text{SiC}_2$  is more rapid than its decomposition and that  $\text{Ti}_3\text{SiC}_2$  with a higher content of TiC and  $\text{TiSi}_2$  is less susceptible to thermal decomposition in vacuum at up to  $1550^\circ\text{C}$ . SRD results show that the thermal dissociation process of  $\text{Ti}_3\text{SiC}_2$  is much more complicated than expected. Further work is required to understand the actual mechanism of high-temperature thermal decomposition in  $\text{Ti}_3\text{SiC}_2$ .

## ACKNOWLEDGEMENTS

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